This Page Is Inserted by IFW Operations and is not a part of the Official Record

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

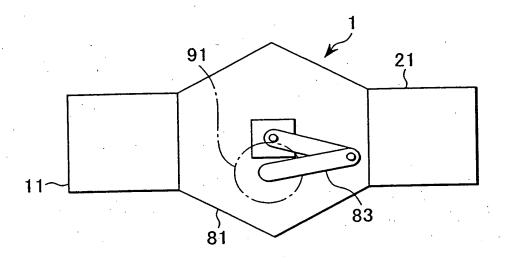
Defects in the images may include (but are not limited to):

- BLACK BORDERS
- TEXT CUT OFF AT TOP, BOTTOM OR SIDES
- FADED TEXT
- ILLEGIBLE TEXT
- SKEWED/SLANTED IMAGES
- COLORED PHOTOS
- BLACK OR VERY BLACK AND WHITE DARK PHOTOS
- GRAY SCALE DOCUMENTS

IMAGES ARE BEST AVAILABLE COPY.

As rescanning documents will not correct images, please do not report the images to the Image Problem Mailbox.

FIG.1

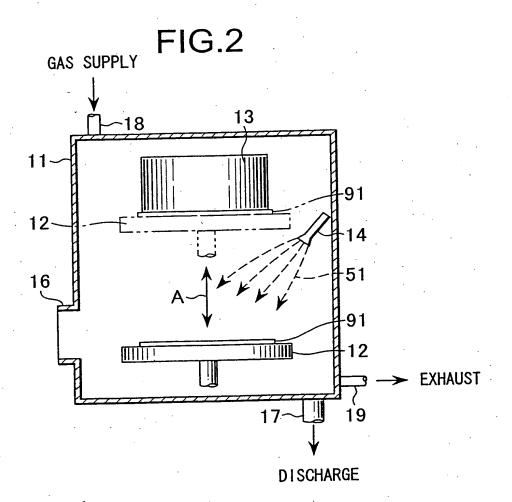


1: FIRST SEMICONDUCTOR MANUFACTURING APPARATUS

11: ELECTROLYTIC PLATING CHAMBER
21: ELECTROLYTIC POLISHING CHAMBER

81: CONVEYING CHAMBER
83: CONVEYING INSTRUMENT

91: SUBSTRATE



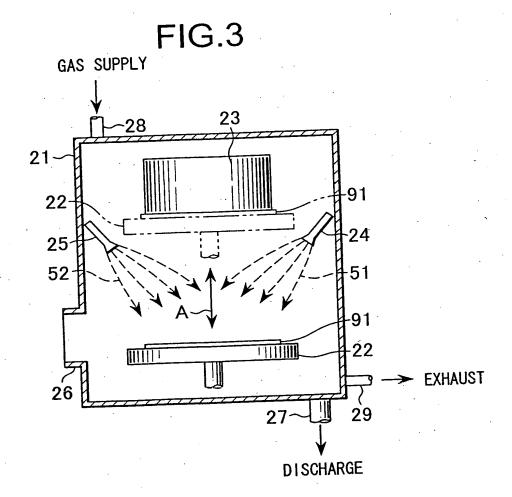


FIG.4

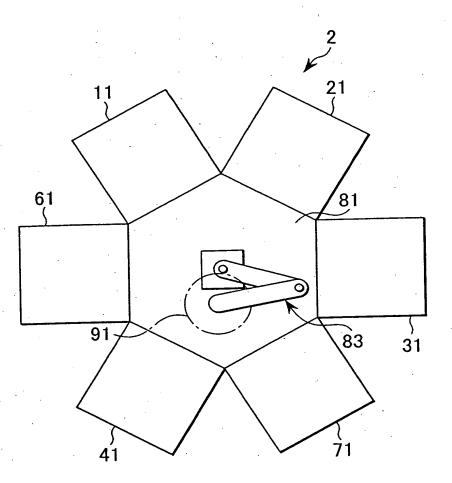


FIG.5

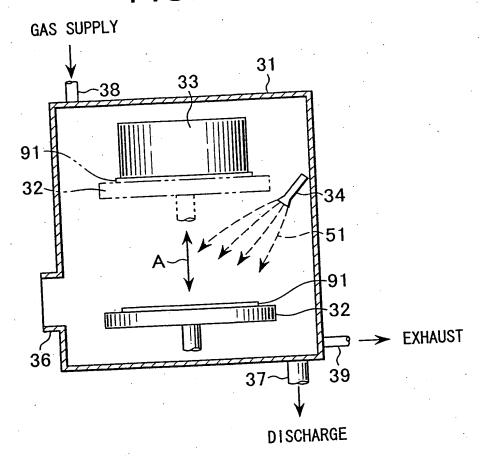


FIG.6

